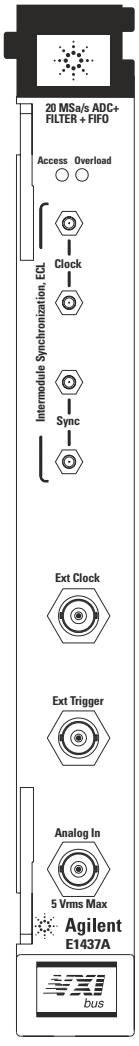
Agilent E1437A

20 MSample/Second ADC with Filter and FIFO

Technical Specifications



Agilent E1437A

Whether you analyze spectra or capture waveforms, the Agilent E1437A ADC will help you see signal features you may have never seen before.

A Remarkable Digitizer

At the heart of the E1437A is an exceptionally low distortion digitizer. Low distortion means high quality data will reveal even more about your signal when averaged, filtered or FFT processed.

Analog Signal Conditioning

You aren't restricted to operating the E1437A at a specific amplitude operating point thanks to built-in analog signal conditioning.

Digital Filtering and LO

Use the 24 real-time digital filters built-in to the E1437A to increase the precision of the output samples, or filter out extraneous signals.

FIFO Memory

The FIFO means you won't lose new samples while you are transferring a data block out.

VXI*plug&play* Programming

The E1437A is VXI*plug&play* compatible and is shipped with software and documentation to support a broad set of controllers, and operating systems.

High Speed Data Transfers

VXI Local Bus capability means the E1437A can output data at 40 MB/s continuously and as high as 60 MB/s when transferring blocks of data.

Specifications

Input	
Input Modes	DC coupled, AC coupled.
	Input grounded, input connected.
	Input BNC shell grounded, floating.
Full Scale Input Ranges (ADC clipping levels, dBm values are approximate)	
Volts peak	**dBm, 50Ω**
10.24V	30
5.12V	24
2.56V	18
1.28V	12
640 mV	6
320 mV	0
160 mV	-6
80 mV	-12
40 mV	-18
20 mV	-24
Maximum Input Level (for any time interval > 10 ms)	10 Vrms for 5.12V and 10.24V ranges, 5 Vrms for all other ranges
Return loss of 50Ω Input Impedance (± 1%, DC coupled, BNC shell grounded, frequency < 8 MHz)	> 40 dB
AC Coupling Characterisitics (A 0.2 µF capacitor is placed in series with the input signal)	0.2 µF (typical) Maximum DC voltage is ± 50V
Common Mode Characteristics	
Shell floating impedance	50Ω in parallel with 0.04 µF (typical)
Shell grounded impedance	< 0.1 (typical)
Maximum Current (diode clamped to < ± 1V peak)	± 1 amp peak
Common Mode Response (Response to a sine wave voltage source of amplitude Vcom (in mV) applied through a 50Ω series resistor; frequency < 8 MHz.)	
Range	**Response in dBfs**
30 dBm to 0 dBm	< (-90 + 20 x LOG(Vcom))
-6 dBm	< (-80 + 20 x LOG(Vcom))
-12 dBm to -24 dBm	< (-65 + 20 x LOG(Vcom))

Accuracy	
Resolution	
Raw ADC resolution	23 bits, two's complement
After digital zoom and filter operations	32 bits, full resolution mode 16 bits, reduced resolution mode
Amplitude Accuracy: (< 100 kHz, 25°C, analog alias filter on, digital decimation filters off, DC coupled)	
Absolute voltage measurement accuracy 12 dBm range	± 0.03 dB
Range accuracy relative to 12 dBm range	± 0.03 dB (for all ranges)
Alias filter off relative to alias filter on mode at 12 kHz	± 0.02 dB
Temperature drift	< 0.001 dB/°C (typical) of deviation from 25 °C
DC offset	
Temperature drift 30 dBm to -6 dBm ranges -12 to -24 dBm ranges	 < ± 0.01%/°C (typical) < ± 0.1 mV/°C (typical)
Input bias current (in parallel with 50Ω input load)	< 64 µA
Flatness (dB peak-to-peak, excluding digital filter response)	
Alias filter on freq < 100 kHz freq < 5 MHz freq < 8 MHz	 < 0.03 dBpp < 0.25 dBpp < 0.80 dBpp
Alias filter off freq < 8 MHz freq < 40 MHz	 < 0.25 dBpp 3 dBpp (typical)
Anti-alias filter stopband rejection (12 MHz to 20 MHz)	> 100 dB

Dynamic Range

NOTE: The performance specifications for the spurious response and discrete sidebands characteristics require that the mainframe containing the E1437A have Option 918 (connector shields E1400-80920) installed. In addition all modules in the mainframe must comply with the VXI 1.4 specification for ECL trigger lines; and the 10-MHz VXI system clock must be turned off. External clock input must be disconnected when not being used for ADC clock.

Signal to Noise Ratio
(The reference signal is a sine wave with peaks at the clipping voltage of the current range; typical values)

Alias filter on	
-6 dBm to 30dBm ranges	71 dB
-12 dBm range	70 dB
-18 dBm range	68 dB
-24 dBm range	65 dB
Alias filter off	
-6 dBm to 30dBm ranges	68 dB
-12 dBm range	66 dB
-18 dBm range	61 dB
-24 dBm range	57 dB

Input Noise Density
(Alias filter on, Internal sample clock)

-6 dBm to 30dBm ranges		
1 MHz to 8 MHz	-140 dBfs/Hz	
100 kHz to 1 MHz	-138 dBfs/Hz	
10 kHz to 100 kHz	-135 dBfs/Hz	
1 kHz to 10 kHz	-131 dBfs/Hz	
10 Hz to 1 kHz	-101 -10*LOG(f) dBfs/Hz	
-12 dBm range		
1 MHz to 8 MHz	-139 dBfs/Hz	-151 dBm/Hz
100 kHz to 1 MHz	-137 dBfs/Hz	-149 dBm/Hz
10 kHz to 100 kHz	-134 dBfs/Hz	-146 dBm/Hz
1 kHz to 10 kHz	-129 dBfs/Hz	-141 dBm/Hz
10 Hz to 1 kHz	-99 -10*LOG(f) dBfs/Hz	-111 -10*LOG(f) dBm/Hz
-18 dBm range		
1 MHz to 8 MHz	-137 dBfs/Hz	-155 dBm/Hz
100 kHz to 1 MHz	-135 dBfs/Hz	-153 dBm/Hz
10 kHz to 100 kHz	-131 dBfs/Hz	-149 dBm/Hz
1 kHz to 10 kHz	-125 dBfs/Hz	-143 dBm/Hz
10 Hz to 1 kHz	-95 -10*LOG(f) dBfs/Hz	-113 -10*LOG(f) dBm/Hz
-24 dBm range		
1 MHz to 8 MHz	-134 dBfs/Hz	-158 dBm/Hz
100 kHz to 1 MHz	-132 dBfs/Hz	-156 dBm/Hz
10 kHz to 100 kHz	-127 dBfs/Hz	-151 dBm/Hz
1 kHz to 10 kHz	-120 dBfs/Hz	-144 dBm/Hz
10 Hz to 1 kHz	-90 -10*LOG(f) dBfs/Hz	-114 -10*LOG(f) dBm/Hz

Spurious Response
(2 kHz to 8 MHz, terminated with 50Ω, input BNC shell grounded)

DSP clock = ADC clock, alias filter on	< -110 dBfs
DSP clock ≠ ADC clock, alias filter on	< -95 dBfs
DSP clock = ADC clock, alias filter off	< -70 dBfs

Phase Noise

Phase noise density
(Single sideband power density of a 5 MHz signal, vibration < 0.05G)

	20 MHz clock	20.48 MHz clock
Δf =100 kHz	< -138 dBc/Hz	< -138 dBc/Hz
Δf =1 kHz	< -130 dBc/Hz	< -130 dBc/Hz
Δf =100 Hz	< -105 dBc/Hz	< -120 dBc/Hz

Discrete sidebands
(100 Hz < Δf < 1 MHz, other modules must comply with VXI 1.4 specification for ECL trigger lines, External Clock disconnected)

Internal clock	< -100 dBc
Internal clock (distributed on backplane with CLK10 backplane clock disabled)	< -80 dBc (typical)

Distortion

Harmonic distortion products to 8 MHz
(Includes aliased distortion components)

for inputs < -6 dBfs	< -75 dBc or < -110 dBfs
for inputs > -6 dBfs	< -70 dBc or < -110 dBfs

Intermodulation Distortion products to 8 MHz
(Includes aliased distortion components)

for inputs < -9 dBfs	< -75 dBc or < -110 dBfs
for inputs > -9 dBfs	< -70 dBc or < -110 dBfs

Clock

Clock Input/Output Characteristics	
External ADC clock input (AC coupled with small-signal input impedance of 100 kΩ above 10 kHz. Large signals are diode clamped through 100Ω)	TTL, ECL, or > -6 dBm sine waves, BNC input
Intermodule Synchronization Clock/SYNC	ECL-10 K compatible, SMB
Clock Source Frequencies	
Internal ADC clock	20 MHz or 20.48 MHz
External sample clock frequency range DSP clock = ADC clock DSP clock ≠ ADC clock	 2 MHz to 20.60 MHz 0 Hz to 20 MHz
DSP clock Internal ADC	 20 MHz or 20.48 MHz ADC clock must be > 2 MHz in this mode
Internal Clock Characteristics	
Frequency Accuracy (20 MHz or 20.48 MHz, 0 °C to 40 °C)	± 100 Hz
Jitter	< 5 ps rms (typical) (see phase noise specification for spectral content of jitter)
Sampling Skew (typical)	
Within mainframe (rear clock distribution)	< 10 ns (typical)
Between mainframes (clock extended via a 1m coaxial cable)	< 25 ns (typical)

Trigger	
Trigger sources	External TTL/ECL/sine wave, level, LOG(magnitude), software (via register write)
Slope	Positive/negative
Threshold	
Level trigger	Vrange x N/128, $-128 \leq N \leq 128$; hysteresis is $\frac{\text{Vrange}}{256}$
LOG (magnitude) trigger	Vrange (dBm) - N x 0.3762574 dBm, $0 \leq N \leq 255$; hysteresis is 1.5 dB
External trigger input	BNC Connector, AC-coupled comparator with 1 kΩ
	TTL/ECL/SINE wave
Sine wave frequency	> 50 kHz
Detects pulses	> 100 ns with edges > 100 mV
Trigger offset	
Resolution (in output sample periods)	1 sample, 32-bit complex data 2 samples, 16-bit complex or 32-bit real data 4 samples, 16-bit real data
Maximum pre-trigger delay	$(132 - \frac{\text{dram size}}{8})$ x trigger offset resolution
Maximum post-trigger delay	16,777,116 x trigger offset resolution

$$H(f) = H_{analog}(f) \bullet H_{digital}\left(N, \frac{f - f_0}{f_s}\right)$$

where:
f = input signal frequency
f_0 = zoom center frequency (zero in baseband mode)
f_s = ADC sampling frequency
N = Digital filter bandwidth selector; N = 0, 1, 2, 3, ..., 24

Analog frequency response function
(typical), with alias filter off.

$$H_{analog} = \prod_{n=1}^{5} \frac{1}{1 - jf / B_n}$$

n	Poles, Bn (MHz)
1	-80.234 +j 0.0
2	-103.94 +j 0.0
3	-103.94 -j 0.0
4	-72.9774 +j 49.94437
5	-72.9774 -j 49.94437

Analog Frequency Response Function
(typical), with alias filter on.

$$H_{analog} = \prod_{n=1}^{11} \frac{1 - jf / A_n}{1 - jf / B_n}$$

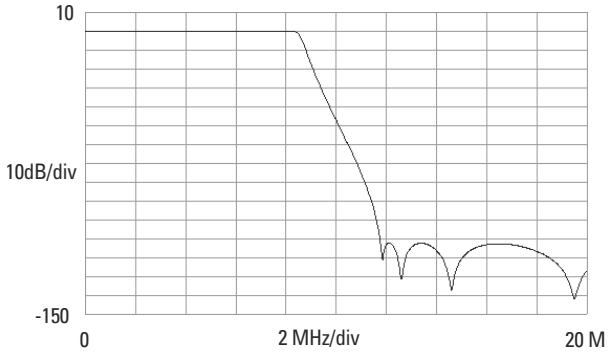
n	Zeros, An (MHz)	Poles, Bn (MHz)
1	∞	-3.423881 +j 0.0
2	-0.278765 + j37.0	-3.122370 +j 3.010688
3	-0.278765 -j 37.0	-3.122370 -j 3.010688
4	-0.085700 +j 19.5	-2.397607 +j 5.453639
5	-0.085700 -j 19.5	-2.397607 -j 5.453639
6	-0.053075 +j 14.6	-1.579759 +j 7.117287
7	-0.053075 -j 14.6	-1.579759 -j 7.117287
8	-0.042453 +j 12.6	-0.864515 +j 8.088296
9	-0.042453 -j 12.6	-0.864515 -j 8.088296
10	-0.038826 +j 11.84	-0.271817 +j 8.524792
11	-0.038826 -j 11.84	-0.271817 -j 8.524792

Digital Frequency response function

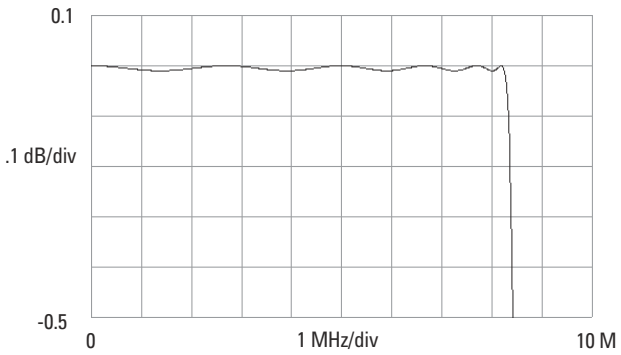
$$H_{digital}\left(N, \frac{f - f_0}{f_s}\right) = \begin{cases} 1, N = 0 \\ \prod_{n=1}^{N}\left(\frac{z^3 + 2z^2 + 2z + 1}{4z^3 + 2z}\right)^5 \Big|_{z = e^{j2\pi p(f-f_0)/f_s}}, N > 0 \end{cases}$$

Filter characteristics for nominal analog alias filter, N = 0

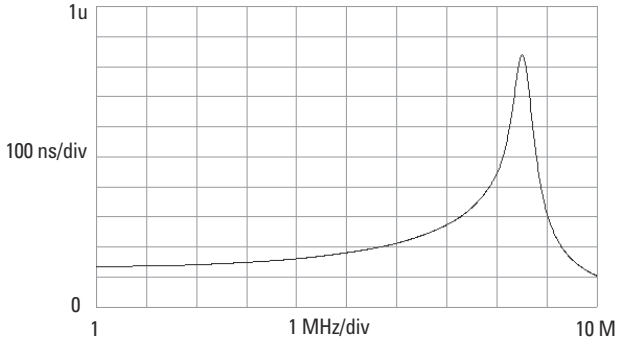
Magnitude (dB) vs. Frequency (Hz)



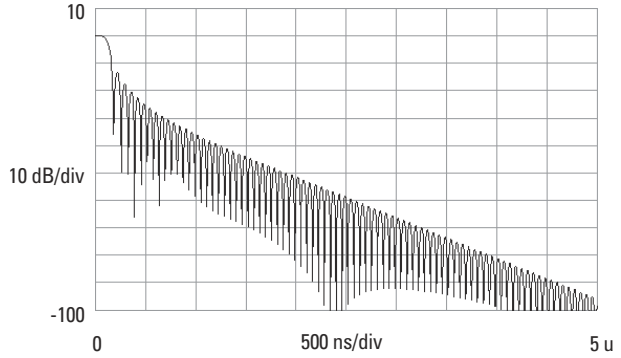
Magnitude (dB) vs. Frequency (Hz)



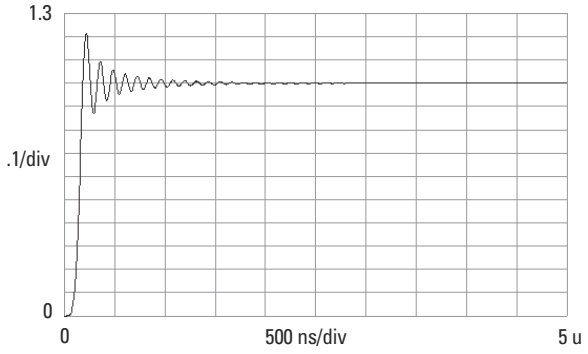
Delay (sec) vs. Frequency (Hz)



Impulse Response (dB) vs. Time (sec)
(normalized to step size)

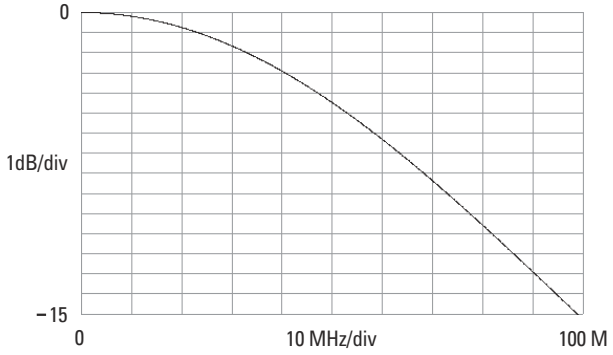


Step Response vs. Time (sec)
(normalized to step size)

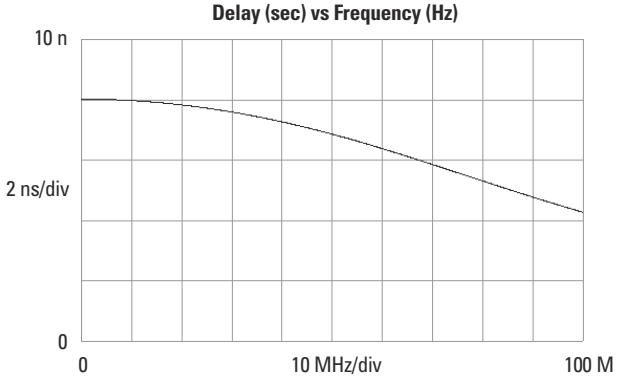


Filter characteristics with all alias filtering turned off, N = 1

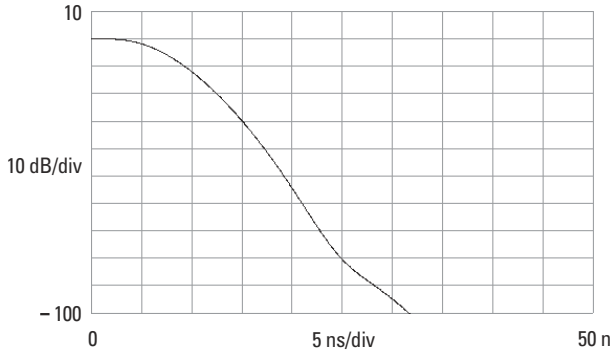
Magnitude (dB) vs Frequency (Hz)



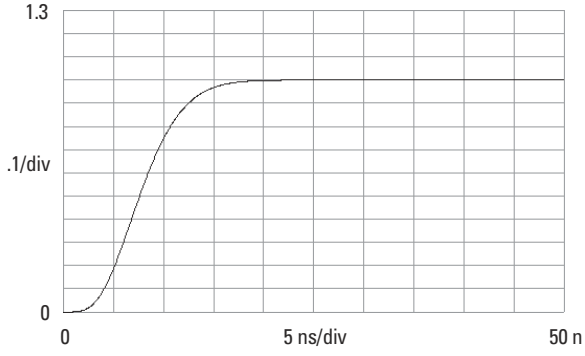
Delay (sec) vs Frequency (Hz)



Log Step Response (dB) vs Time (sec)
(normalized to step size)

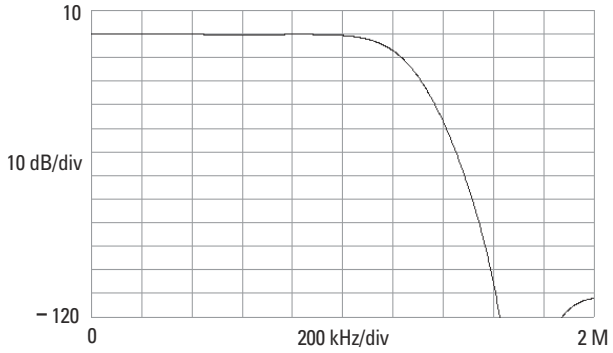


Step Response vs Time (sec)
(normalized to step size)

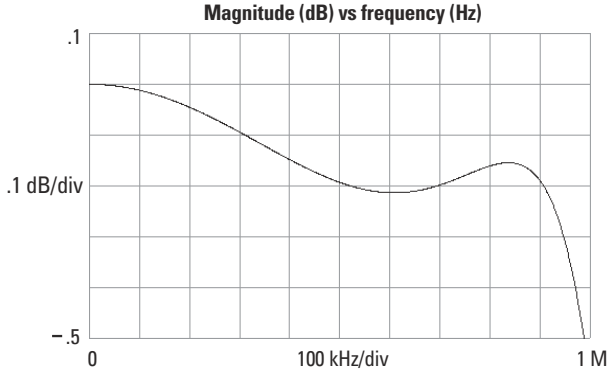


Filter characteristics for 3rd pass digital filter + analog filter (dominated by digital), N = 3

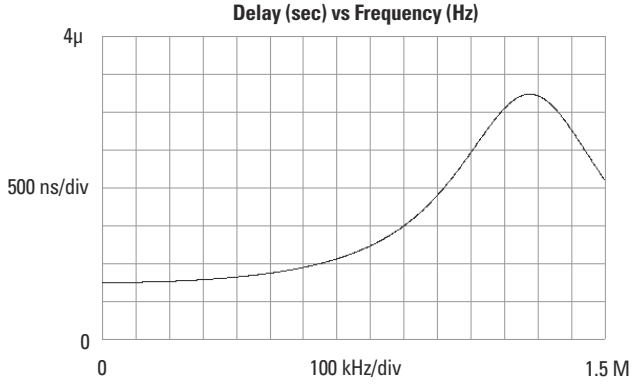
Magnitude (dB) vs Freqency (Hz)



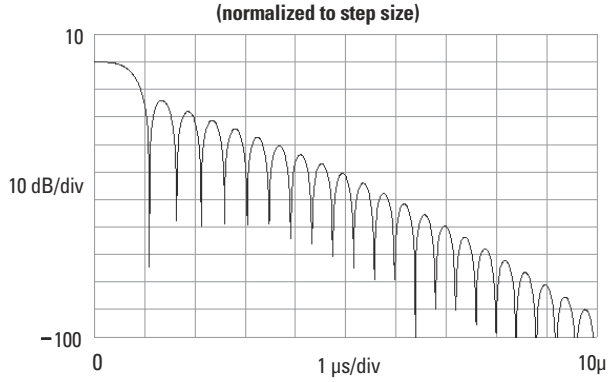
Magnitude (dB) vs frequency (Hz)



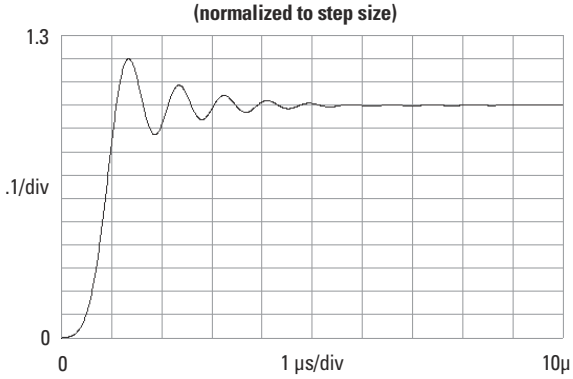
Delay (sec) vs Frequency (Hz)



Step Response (dB) vs Time (sec)
(normalized to step size)



Step Response vs Time (sec)
(normalized to step size)



Programming	
(all functions are programmable via the VXI register interface)	
Center frequency	
Resolution	ADC clock frequency ÷ (1024 ˘ 10^9)
Range	± ADC clock frequency ÷ 2
Filtering and decimation	
Bandwidths (-15 dB) (See the frequency response section for filter characteristics)	± 0.5 ˘ $Fs/2^N$, $0 \leq N \leq 24$
Output sample rate	$Fs/2^N$ (nyquist sampled) 2 ˘ $Fs/2^N$ (2X over-sampled)
Data output	
Type	real, complex
Resolution	16 bits, 32 bits
Output ports	VME data transfers Local Bus data transfers
Transfer rate	60 MByte/s, burst 40 MByte/s, sustained 2 MByte/s,VME
Block sizes	8, 16, 32, ..., up to memory size bytes
Measurement modes	Block mode (individually triggered blocks) Continuous mode
Information available in read registers	
Manufacturer's code	4095 decimal (Agilent Technologies)
Model code	534 decimal (E1437A)
Other Status bits	Measurement loop status, Ready, ADC error, Ext clk error, Set-up error, Sync/Idle complete, Read Valid, Measure done, Armed, FIFO overflow, Overload, Error, Mod ID, Hardware set.
Interrupts	Two independent priority interrupts initiated by masked status bits
Memory	
Type	FIFO
Capacity	8 MBytes (4 MSamples, 16 bits) 16 MBytes (8 MSamples,16 bits) option UFC 32 MBytes (16 MSamples, 16 bits) option ANC 64 MBytes (32 MSamples, 16 bits) option ANE

VXI System Level Specifications	
VXI Standard Information	Conforms to VXI Rev. 1.4
	C-size, single slot width
	Register/Message based programming
	"Slave" Data Transfer Bus functionality
	A16 address capability
	D16 data capability
	Local Bus capability
	Requires ECLTRG0 and ECLTRG1 lines for module synchronization
Size (single slot, C-size VXI module)	
Dimensions	14 inches deep, 9.2 inches high, 1.2 inches wide (approx 36 cm deep, 23 cm high, 3 cm wide)
Weight	3.9 pounds (approx 1.8 kg)
Software Drivers	
Driver Type	C libraries with source code
Supported Operating Systems	MS Windows® 3.1, Windows 95, Windows NT®, HP-UX* 9.X
Supply Media	Disk, DAT

* HP-UX 9.X and 10.0 for HP 9000 Series 700 and 800 computers are X/Open Company UNIX 93 branded products.

Regulatory Compliance	
Safety Standards	Designed for compliance to CSA C22.2, No. 231 Designed for compliance to UL 1244, 4th Edition Designed for compliance to IEC 348, 2nd Edition, 1978
Radiated Emissions	CISPR 11 :1990 Group 1, Class A (requires connector shields E1400-80920 in the mainframe)
Environmental	
Operating Restrictions	
Ambient Temperature	0° to 55° C
Humidity, Non-condensing	10% to 90% at 40° C
Maximum Altitude	4600m (15,000 ft) Above 2285m (7500 ft), derate operating temperature by -3.6° C per 1000m (-1.1° C per 1000 ft)
Storage and Transport Restrictions	
Ambient Temperature	40° to 70° C
Humidity, Non-condensing	max 95% RH at 65° C
Maximum Altitude	4600m (15,000 ft)

General Characteristics

VXI Power Requirements

Range	DC Current	Dynamic Current
+5V	5.0A	0.50A
-5.2V	5.0A	0.50A
-2V	0.3A	0.10A
+12V	1.0A	0.050A
-12V	1.2A	0.050A
+24V	0.0A	0.0A
-24V	0.0A	0.0A

VXI Cooling Requirements 15° C rise	4.0 liters/second 0.5 mm H_2O
Calibration interval	1 year
Warm-up time	15 minutes

Warranty

This product is distributed, warranted, and supported by Agilent Technologies.

The E1437A comes with a 3-year warranty. During that period, the unit will either be replaced or repaired, at Agilent Technologies' option, and returned to the customer without charge.

Ordering Information

Agilent E1437A	20 MSa/s AD with filter and FIFO
Option UFC	16 MB FIFO memory
Option ANC	32 MB FIFO memory
Option ANE	64 MB FIFO memory
Option 0B0	Delete manual set
Option 0B1	Add manual set

Specification Note

Specifications describe warranted performance over the temperature range of 0° to 55 °C, after a 15-minute warm-up from ambient conditions and automatic calibrations enabled unless otherwise noted. Supplemental characteristics identified as "typical" or "characteristic," provide useful information by giving non-warranted performance parameters. Typical performance is applicable from 20° to 30 °C.

Abbreviations

dBm = dB relative to 1 mW into 50Ω

dBfs = dB relative to full scale amplitude range.

dBc = dB relative to carrier amplitude.

Typical = typical, non-warranted, performance specification included to provide general product information.

Related Agilent Literature

E1437A 20 MSample/Second ADC with Filter and FIFO Product Overview
literature number 5965-6893E

E1438A 100 MSample/Second Digitizer with DSP and Memory Product Overview
literature number 5968-7348E

E1438A 100 MSample/Second Digitizer with DSP and Memory Technical Specifications
literature number 5968-8233E

E1439A VXI 70MHz IF ADC with Filters and Memory Product Overview
literature number 5980-1261E

E1439A VXI 70MHz IF ADC with Filters and Memory Technical Specifications
literature number 5980-1260E

E9830A Delay Memory Module Product Overview
literature number 5968-7349E

Test Systems and VXI Products Catalog
literature number 5980-0307E

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Agilent VXI Product Information — www.agilent.com/find/vxi

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